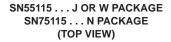
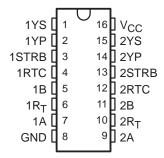
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- Choice of Open-Collector or Active Pullup (Totem-Pole) Outputs
- Single 5-V Supply
- Differential Line Operation
- Dual-Channel Operation
- TTL Compatible
- ±15-V Common-Mode Input Voltage Range
- Optional-Use Built-In 130-Ω Line-Terminating Resistor
- Individual Frequency Response Controls
- Individual Channel Strobes
- Designed for Use With SN55113, SN75113, SN55114, and SN75114 Drivers
- Designed to Be interchangeable With National DS9615 Line Receivers

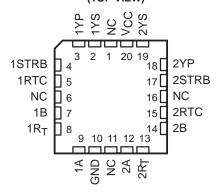
### description

The SN55115 and SN75115 dual differential line receivers are designed to sense small differential signals in the presence of large common-mode noise. These devices give TTL-compatible output signals as a function of the differential input voltage. The open-collector output configuration permits the wire-ANDing of similar TTL outputs (such as SN5401/SN7401) or other SN55115/SN75115 line receivers. This permits a level of logic to be implemented without extra





# SN55114 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

delay. The output stages are similar to TTL totem-pole outputs, but with sink outputs, 1YS and 2YS, and the corresponding active pullup terminals, 1YP and 2YP, available on adjacent package pins. The frequency response and noise immunity may be provided by a single external capacitor. A strobe input is provided for each channel. With the strobe in the low level, the receiver is disabled and the outputs are forced to a high level.

The SN55115 is characterized for operation over the full military range of  $-55^{\circ}$ C to 125°C. The SN75115 is characterized for operation from 0°C to 70°C.

#### **FUNCTION TABLE**

STRB	DIFF INPUT (A AND B)	OUTPUT (YP AND YS TIED TOGETHER)
L	Х	Н
Н	L	Н
Н	Н	L

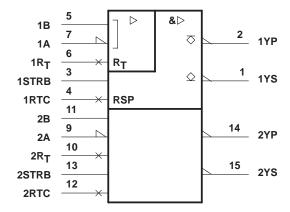
 $H = V_1 \ge V_{1H}$  min or  $V_{1D}$  more positive than  $V_{T+}$  max  $L = V_1 \le V_{1L}$  max or  $V_{1D}$  more negative than  $V_{T-}$  max X = irrelevant



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

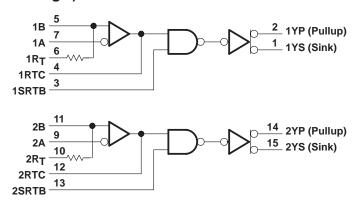


## logic symbol†

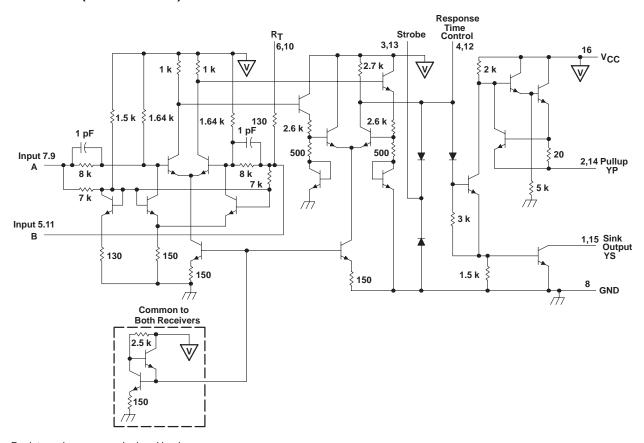


<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

# logic diagram (positive logic)



### schematic (each receiver)



Resistor values are nominal and in ohms.

Pin numbers shown are for J, N, and W packages.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	SN55115	SN75115	UNIT	
Supply voltage, V <sub>CC</sub> (see Note 1)	7	7	V	
Input voltage, V <sub>I</sub> (A, B, and R <sub>T</sub> )	±25	±25	V	
Input voltage, V <sub>I</sub> (STRB)	5.5	5.5	V	
Off-state voltage applied to open-collector outputs	14	14 14		
Continuous total power dissipation	See Dissipation Rating Table			
Operating free-air temperature range, T <sub>A</sub>	-55 to 125 0 to 70		°C	
Storage temperature range, T <sub>Stg</sub>	-65 to 150	-65 to 150	°C	
Case temperature for 60 seconds: FK package	260		°C	
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J or W package	300		°C	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: N package		260	°C	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential input voltage, are with respect to network ground terminal.



# SN55115, SN75115 DUAL DIFFERENTIAL RECEIVERS

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### DISSIPATION RATING TABLE

PACKAGE	T <sub>A</sub> ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	<b>A</b>	
FK <sup>‡</sup>	1375 mW	11.0 mW/°C	880 mW	275 mW
J†	1375 mW	11.0 mW/°C	880 mW	275 mW
N	1150 mW	9.2 mW/°C	736 mW	_
wt	1000 mW	8.0 mW/°C	640 mW	200 mW

<sup>‡</sup> In the FK, J, and W packages, SN55115 chips are either silver glass or alloy mounted. SN75115 chips are glass mounted.

### recommended operating conditions

	SN55115			ý	UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>	4.5	5	5.5	4.75	5	5.25	V
High-level input voltage at STRB, V <sub>IH</sub>	2.4			2.4			V
Low-level input voltage at STRB, V <sub>IL</sub>			0.4			0.4	V
High-level output current, IOH			-5			-5	mA
Low-level output current, IOL			15			15	mA
Operating free-air temperature, TA	-55		125	0		70	°C

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPITIONS!			SN55115			SN75115			
PARAMETER	IES	CONDITIONS		MIN	TYP <sup>‡</sup>	MAX	MIN	TYP <sup>‡</sup>	MAX	UNIT
Positive-going threshold voltage	V <sub>O</sub> = 0 .4 V,	I <sub>OL</sub> = 15 mA,	VIC = 0			500			500	mV
Negative-going threshold voltage	V <sub>O</sub> = 2 .4 V,	$I_{OH} = -5 \text{ mA},$	VIC = 0	-500¶			-500¶			mV
Common-mode input voltage range	V <sub>ID</sub> = ±1 V			+ 15 to – 15	+24 to -19		+15 to -15	+24 to -19		V
	.,		$T_A = MIN$	2.2			2.4			
•		VID = -0.5 V,	$T_A = 25^{\circ}C$	2.4	3.4		2.4	3.4		V
	-011		$T_A = MAX$	2.4			2.4			
Low-level output voltage	$V_{CC} = MIN,$ $I_{OL} = 15 \text{ mA}$	$V_{ID} = -0.5 V$ ,			0.22	0.4		0.22	0.45	V
Low-level input current	onput V <sub>CC</sub> = MAX, V Other input at 5.5 V		$T_A = MIN$			-0.9			-0.9	mA
			T <sub>A</sub> = 25°C		-0.5	-0.7		-0.5	-0.7	
			$T_A = MAX$			-0.7			-0.7	
High-level strobe	$V_{CC} = MIN,$	$V_{ID} = -0.5 V$ ,	$T_A = 25^{\circ}C$			2			5	μΑ
current	V <sub>strobe</sub> = 4.5 V		$T_A = MAX$			5			10	μА
Low-level strobe current	V <sub>CC</sub> = MAX, V <sub>strobe</sub> = 0.4 V	$V_{ID} = 0.5 V,$	T <sub>A</sub> = 25°C		-1.15	-2.4		-1.15	-2.4	mA
Response-time- control current	$V_{CC} = MAX,$ $V_{RC} = 0$	$V_{ID} = 0.5 V,$	T <sub>A</sub> = 25°C	-1.2	-3.4		-1.2	-3.4		mA
	V <sub>CC</sub> = MIN,	V <sub>OH</sub> = 12 V,	T <sub>A</sub> = 25°C			100				
	$V_{ID} = -4.5 \text{ V}$		$T_A = MAX$			200				μΑ
'	V <sub>CC</sub> = MIN,	V <sub>OH</sub> = 5.25 V,	$T_A = 25^{\circ}C$						100	μΑ
	$V_{ID} = -4.75 \text{ V}$		$T_A = MAX$						200	
Line-terminating resistance	V <sub>CC</sub> = 5 V		T <sub>A</sub> = 25°C	77	130	167	74	130	179	Ω
Supply-circuit output current#	$V_{CC} = MAX,$ $V_{O} = 0$	$V_{ID} = -0.5 V,$	T <sub>A</sub> = 25°C	-15	-40	-80	-14	-40	-100	mA
Supply current (both receivers)	V <sub>CC</sub> = MAX, V <sub>IC</sub> = 0	V <sub>ID</sub> = 0.5 V,	T <sub>A</sub> = 25°C		32	50		32	50	mA
	threshold voltage  Negative-going threshold voltage  Common-mode input voltage range  High-level ouput voltage  Low-level output voltage  Low-level input current  High-level strobe current  Component output voltage  Low-level input current  Low-level strobe current  Low-level strobe current  Response-time-control current  Off-state open-collector output current  Line-terminating resistance  Supply-circuit output current#  Supply current	Positive-going threshold voltage  Negative-going threshold voltage  Vo = 0.4 V,  Vo = 2.4 V,  Common-mode input voltage range  ViD = $\pm 1$ V  High-level ouput voltage  Low-level output voltage  Low-level input current  Vic = MIN, IoL = 15 mA  Vig = $\pm 15$ mA	Positive-going threshold voltage $V_{O} = 0.4 \text{ V}, \qquad I_{OL} = 15 \text{ mA},$ $Negative-going threshold voltage V_{O} = 2.4 \text{ V}, \qquad I_{OH} = -5 \text{ mA}, Common-mode input voltage range \qquad V_{ID} = \pm 1 \text{ V} High-level ouput voltage \qquad V_{CC} = MIN, I_{OH} = -0.5 \text{ V}, I_{OH} = -5 \text{ mA} \qquad V_{ID} = -0.5 \text{ V}, I_{OH} = -5 \text{ mA} \qquad V_{ID} = -0.5 \text{ V}, I_{OH} = -15 \text{ mA} \qquad V_{ID} = -15 \text{ mA}, I_{OH} = -15 \text{ mA} \qquad V_{ID} = -15 \text{ mA}$	$\begin{array}{c} Positive-going \\ threshold voltage \\ \hline Negative-going \\ threshold voltage \\ \hline \\ Negative-going \\ threshold voltage \\ \hline \\ Common-mode \\ input voltage range \\ \hline \\ VID = \pm 1 \ V \\ \hline \\ VID = \pm 1 \ V \\ \hline \\ VID = \pm 1 \ V \\ \hline \\ VID = -0.5 \ V, \\ \hline \\ VID = -0.5 \ V$	PARAMETER         TEST CONDITIONST         MIN           Positive-going threshold voltage         VO = 0.4 V, IOL = 15 mA, VIC = 0         VIC = 0           Negative-going threshold voltage         VO = 2.4 V, IOH = -5 mA, VIC = 0         −500 ff           Common-mode input voltage range         VID = ±1 V         TA = MIN         2.2           High-level ouput voltage         VCC = MIN, IOH = -5 mA         VID = -0.5 V, ITA = MAX         2.4           Low-level output voltage         VCC = MIN, IOL = 15 mA         VID = -0.5 V, ITA = MIN         TA = MIN         2.4           Low-level input current         VCC = MAX, VID = 0.4 V, Other input at 5.5 V         TA = MIN         TA = MIN         TA = MIN         TA = 25°C         TA = MAX         TA = MIN         TA = 25°C         TA = MAX         TA = MIN         TA = 25°C         TA = MIN         TA = 25°C         TA = MAX         TA = 25°C         TA = MAX         TA = 25°C         TA = 25°C         TA = 25°C         TA = 25°C <td< td=""><td>PARAMETER         TEST CONDITIONST         MIN         TYP‡           Positive-going threshold voltage         VO = 0.4 V.         IOL = 15 mA, VIC = 0         VIC = 0           Negative-going threshold voltage         VO = 2.4 V.         IOH = -5 mA, VIC = 0         -500¶           Common-mode input voltage range         VID = ±1 V         +15</td><td>  PARAMETER</td><td><math display="block"> \begin{array}{c ccccccccccccccccccccccccccccccccccc</math></td><td>  PARAMETER   TEST CONDITIONST   MIN TYP‡ MAX MIN TYP‡   Positive-going threshold voltage   VO = 0.4 V,</td><td><math display="block"> \begin{array}{c ccccccccccccccccccccccccccccccccccc</math></td></td<>	PARAMETER         TEST CONDITIONST         MIN         TYP‡           Positive-going threshold voltage         VO = 0.4 V.         IOL = 15 mA, VIC = 0         VIC = 0           Negative-going threshold voltage         VO = 2.4 V.         IOH = -5 mA, VIC = 0         -500¶           Common-mode input voltage range         VID = ±1 V         +15	PARAMETER	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	PARAMETER   TEST CONDITIONST   MIN TYP‡ MAX MIN TYP‡   Positive-going threshold voltage   VO = 0.4 V,	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

 $<sup>\</sup>dagger$  Unless otherwise noted,  $V_{strobe} = 2.4 \text{ V}$ . All parameters with the exception of off-state open-collector output current are measured with the active pull-up connected to the sink output.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C, and V<sub>IC</sub> = 0.

§ Differential voltages are at the B input terminal with respect to the A input terminal.

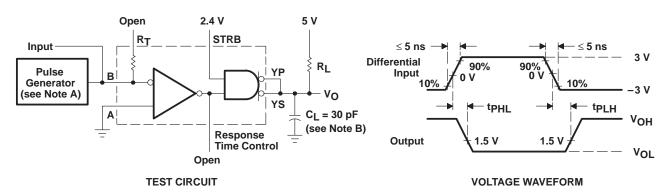
The algebraic convention, in which the less positive (more negative) limit is designated as minimum, is used in this data sheet for threshold voltages only.

<sup>#</sup>Only one output should be shorted to ground at a time, and duration of the short circuit should not exceed one second.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $C_L = 30 \text{ pF}$ , $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST CONDITIONS		SN55115			SN75115			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	OIALL
<sup>t</sup> PLH	Propagation delay time, low-to-high level output	$R_L = 3.9 \text{ k}\Omega$ , See	e Figure 1		18	50		18	75	ns
<sup>t</sup> PHL	Propagation delay time, high-to-low level output	$R_L = 390 \Omega$ , See	e Figure 1		20	50		20	75	ns

### PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics:  $Z_{O} = 50~\Omega$ , PRR  $\leq 500~kHz$ ,  $t_{W} \leq 100~ns$ , duty cycle = 50%.

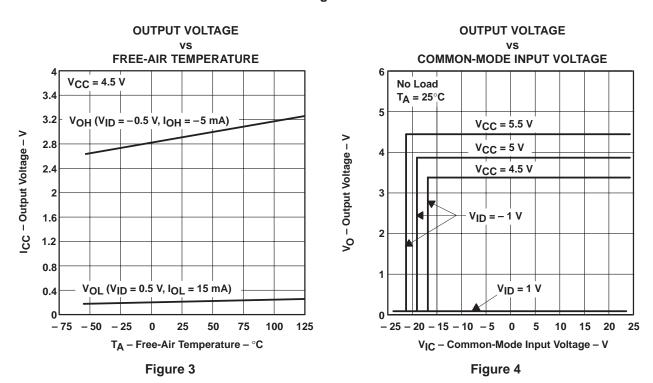
B. C<sub>L</sub> includes probe and jig capacitance.

Figure 1. Test Circuit and Voltage Waveforms

### TYPICAL CHARACTERISTICS<sup>†</sup>

# **INPUT CURRENT** ٧S **INPUT VOLTAGE** $V_{CC} = 5 V$ Input Not Under Test at 0 V $T_A = 25^{\circ}C$ I<sub>I</sub> - Input Current - mA 2 0 **- 2** 0 -25 -20 -15 -10 -55 10 15 20 V<sub>I</sub> - Input Voltage - V

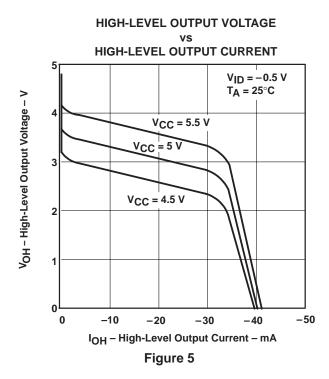
Figure 2

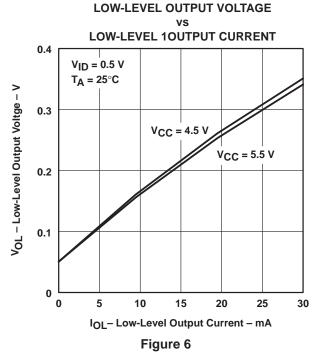


<sup>†</sup> Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75 V and above 5.25 V are applicable to SN55115 circuits only. These parameters were measured with the active pullup connected to the sink output.



### TYPICAL CHARACTERISTICS





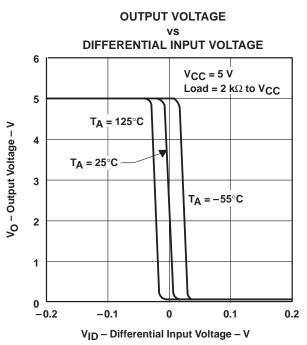
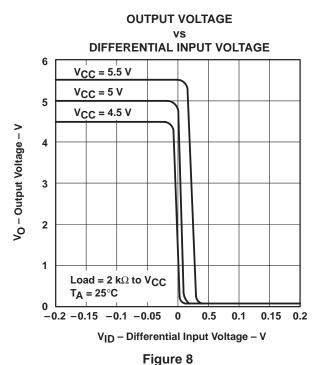
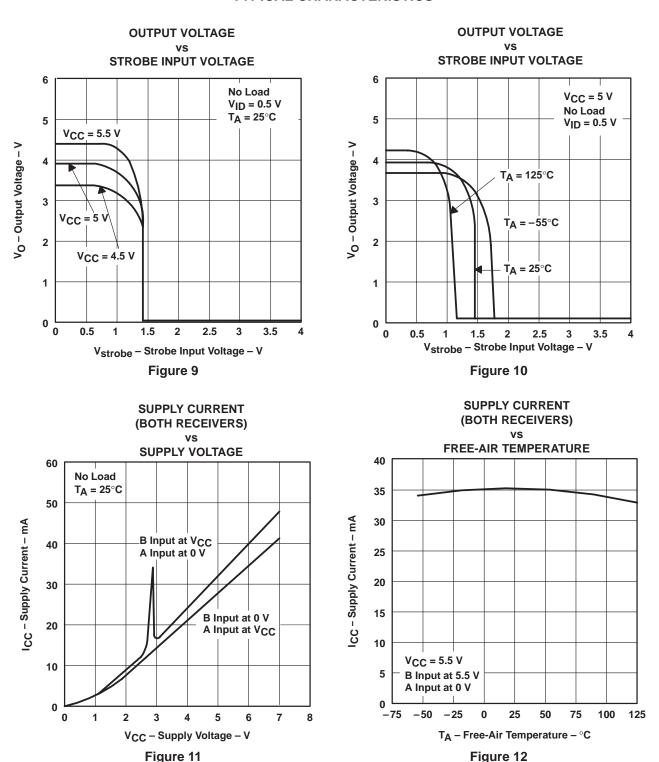


Figure 7



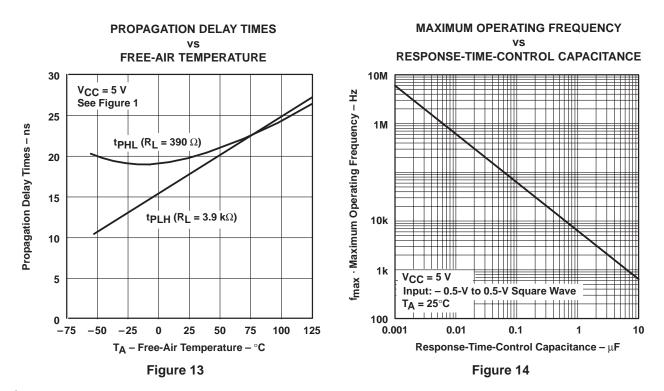
### TYPICAL CHARACTERISTICS<sup>†</sup>



<sup>†</sup> Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75 V and above 5.25 V are applicable to SN55115 circuits only. These parameters were measured with the active pullup connected to the sink output.



### TYPICAL CHARACTERISTICS<sup>†</sup>



<sup>†</sup> Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75 V and above 5.25 V are applicable to SN55115 circuits only. These parameters were measured with the active pullup connected to the sink output.

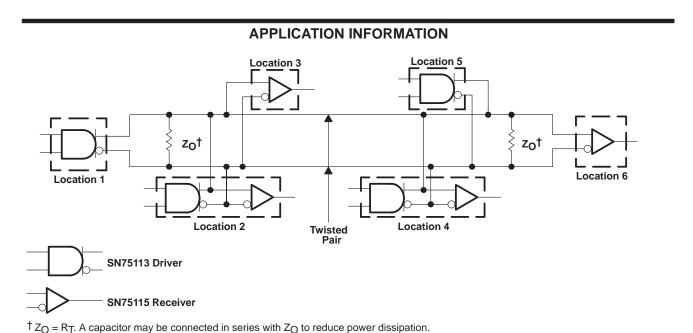


Figure 15. Basic Party-Line or Data-Bus Differential Data Transmission



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